

# HCD65R830

## 650V N-Channel Super Junction MOSFET

### Features

- Very Low FOM ( $R_{DS(on)} \times Q_g$ )
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode

### Key Parameters

| Parameter              | Value | Unit     |
|------------------------|-------|----------|
| $BV_{DSS} @ T_{j,max}$ | 700   | V        |
| $I_D$                  | 5.5   | A        |
| $R_{DS(on), max}$      | 0.83  | $\Omega$ |
| $Q_g, Typ$             | 11.2  | nC       |

### Application

- Switch Mode Power Supply (SMPS)
- TV power & LED Lighting Power
- AC to DC Converters
- Telecom

### Package & Internal Circuit

| D-PAK | SYMBOL |
|-------|--------|
|       |        |

### Absolute Maximum Ratings

$T_C=25^\circ\text{C}$  unless otherwise specified

| Symbol         | Parameter   | Value       | Unit             |
|----------------|---|-------------|------------------|
| $V_{DSS}$      | Drain-Source Voltage  | 650         | V                |
| $V_{GS}$       | Gate-Source Voltage   | $\pm 20$    | V                |
| $I_D$          | Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )                 | 5.5         | A                |
|                | Drain Current - Continuous ( $T_C = 100^\circ\text{C}$ )                | 3.5         | A                |
| $I_{DM}^1)$    | Drain Current - Pulsed  | 16.5        | A                |
| $E_{AS}^2)$    | Single Pulsed Avalanche Energy  | 57          | mJ               |
| $I_{AR}$       | Avalanche Current   | 1.15        | A                |
| $dv/dt$        | MOSFET $dv/dt$ ruggedness, $V_{DS}=0\dots 400\text{V}$                  | 50          | V/ns             |
| $dv/dt$        | Reverse diode $dv/dt$ , $V_{DS}=0\dots 400\text{V}$ , $I_{DS} \leq I_D$ | 15          | V/ns             |
| $P_D$          | Power Dissipation ( $T_C = 25^\circ\text{C}$ )                          | 55          | W                |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                                 | -55 to +150 | $^\circ\text{C}$ |

### Thermal Resistance Characteristics

| Symbol          | Parameter                                      | Value | Unit                      |
|-----------------|--|-------|---------------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case, Max.     | 2.27  | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient , Max. | 62.5  | $^\circ\text{C}/\text{W}$ |

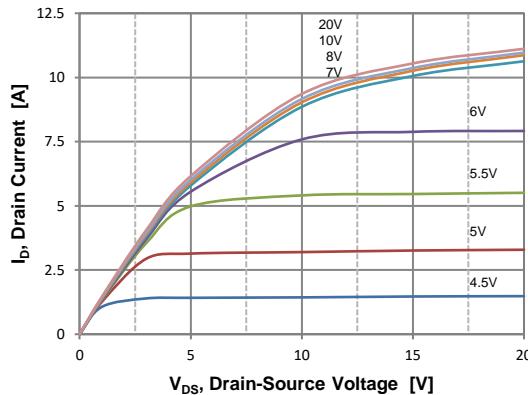
**Electrical Characteristics**  $T_J=25\text{ }^{\circ}\text{C}$  unless otherwise specified

| Symbol  | Parameter   | Test Conditions  | Min | Typ  | Max     | Unit          |
|---|---|--|-----|------|---------|---------------|
| <b>On Characteristics</b>                                     |   |  |     |      |         |               |
| $V_{GS}$  | Gate Threshold Voltage                                | $V_{DS} = V_{GS}$ , $I_D = 170\text{ }\mu\text{A}$   | 2.0 | -    | 4.0     | V             |
| $R_{DS(ON)}$  | Static Drain-Source On-Resistance                     | $V_{GS} = 10\text{ V}$ , $I_D = 1.6\text{ A}$  | -   | 0.72 | 0.83    | $\Omega$      |
| <b>Off Characteristics</b>                                    |   |  |     |      |         |               |
| $BV_{DSS}$  | Drain-Source Breakdown Voltage                        | $V_{GS} = 0\text{ V}$ , $I_D = 1\text{ mA}$  | 650 | -    | -       | V             |
| $I_{DSS}$   | Zero Gate Voltage Drain Current                       | $V_{DS} = 650\text{ V}$ , $V_{GS} = 0$   | -   | -    | 1       | $\mu\text{A}$ |
|   |   | $V_{DS} = 650\text{ V}$ , $T_C = 150^{\circ}\text{C}$                                      | -   | -    | 100     | $\mu\text{A}$ |
| $I_{GSS}$   | Gate-Body Leakage Current                             | $V_{GS} = \pm 20\text{ V}$ , $V_{DS} = 0\text{ V}$   | -   | -    | $\pm 1$ | $\mu\text{A}$ |
| <b>Dynamic Characteristics</b>                                |   |  |     |      |         |               |
| $C_{iss}$   | Input Capacitance                                     | $V_{DS} = 400\text{ V}$ , $V_{GS} = 0\text{ V}$ ,<br>$f = 1.0\text{ MHz}$                  | -   | 467  | -       | pF            |
| $C_{oss}$   | Output Capacitance                                    |  | -   | 15   | -       | pF            |
| $C_{rss}$   | Reverse Transfer Capacitance                          |  | -   | 2.6  | -       | pF            |
| <b>Switching Characteristics</b>                              |   |  |     |      |         |               |
| $t_{d(on)}$   | Turn-On Time  | $V_{DS} = 325\text{ V}$ , $I_D = 2.2\text{ A}$ ,<br>$R_G = 25\text{ }\Omega$<br>(Note 3,4) | -   | 21   | -       | ns            |
| $t_r$   | Turn-On Rise Time                                     |  | -   | 19   | -       | ns            |
| $t_{d(off)}$  | Turn-Off Delay Time                                   |  | -   | 62   | -       | ns            |
| $t_f$   | Turn-Off Fall Time                                    |  | -   | 19   | -       | ns            |
| $Q_{g(}}$   | Total Gate Charge                                     | $V_{DS} = 520\text{ V}$ , $I_D = 2.2\text{ A}$ ,<br>$V_{GS} = 10\text{ V}$<br>(Note 3,4)   | -   | 11.2 | -       | nC            |
| $Q_{gs}$  | Gate-Source Charge                                    |  | -   | 2.2  | -       | nC            |
| $Q_{gd}$  | Gate-Drain Charge                                     |  | -   | 3.7  | -       | nC            |
| <b>Drain-Source Diode Characteristics and Maximum Ratings</b> |   |  |     |      |         |               |
| $I_S$   | Maximum Continuous Drain-Source Diode Forward Current | -  | -   | 5.5  | A       |               |
| $I_{SM}$  | Maximum Pulsed Drain-Source Diode Forward Current     | -  | -   | 16.5 | A       |               |
| $V_{SD}$  | Drain-Source Diode Forward Voltage                    | $V_{GS} = 0\text{ V}$ , $I_S = 2.2\text{ A}$   | -   | -    | 1.3     | V             |
| $trr$   | Reverse Recovery Time                                 | $V_R = 400\text{ V}$ , $I_F = 2.2\text{ A}$<br>$dI_F/dt = 100\text{ A}/\mu\text{s}$        | -   | 225  | -       | ns            |
| $Qrr$   | Reverse Recovery Charge                               |  | -   | 1.3  | -       | $\mu\text{C}$ |

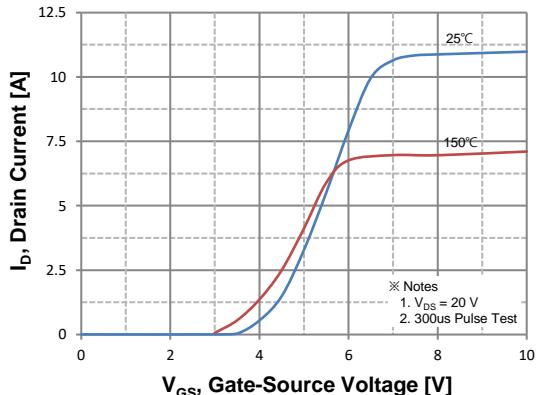
**Notes :**

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=1.15\text{ A}$   $V_{DD}=50\text{ V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^{\circ}\text{C}$
- Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- Essentially Independent of Operating Temperature

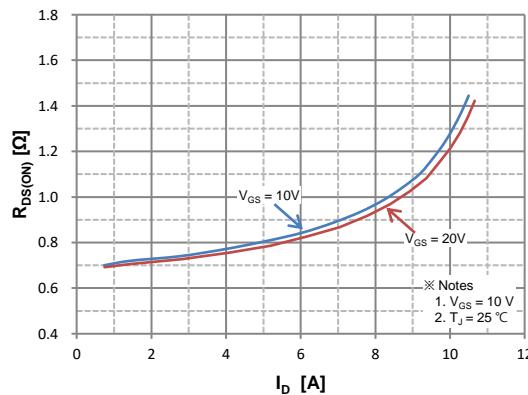
## Typical Characteristics



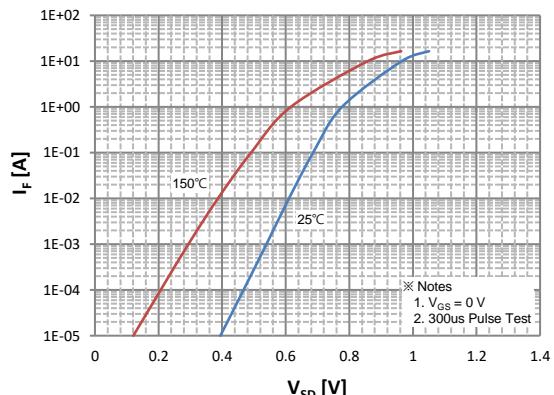
**Figure 1. On Region Characteristics**



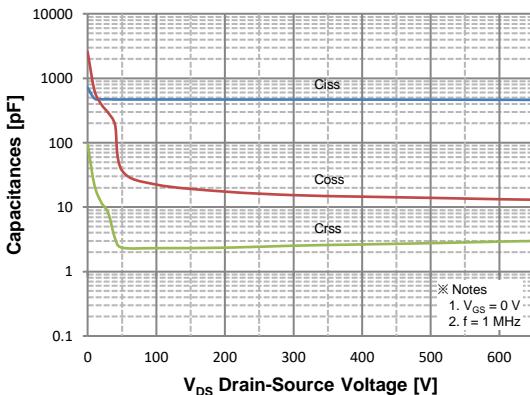
**Figure 2. Transfer Characteristics**



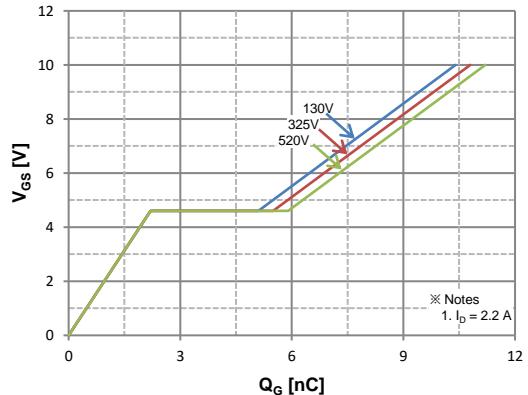
**Figure 3. On Resistance Variation vs Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

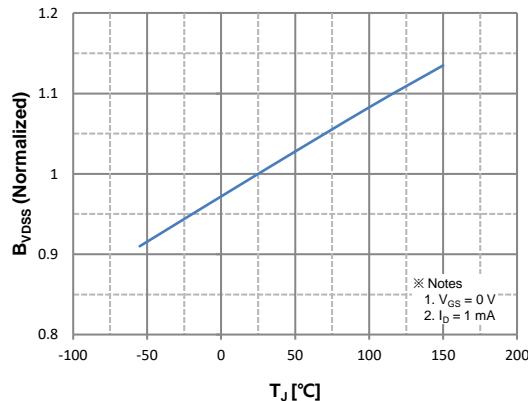


**Figure 5. Capacitance Characteristics**

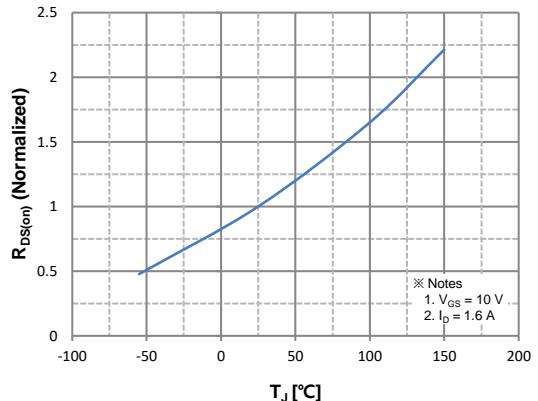


**Figure 6. Gate Charge Characteristics**

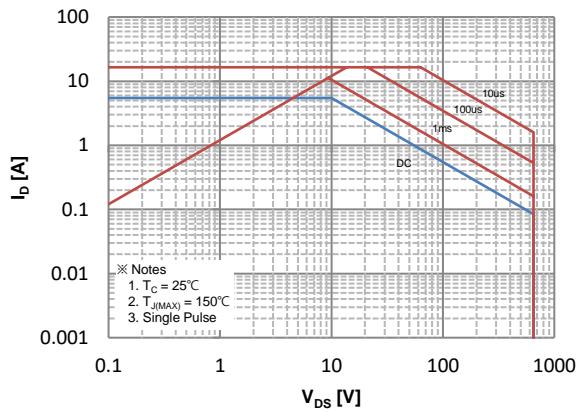
## Typical Characteristics



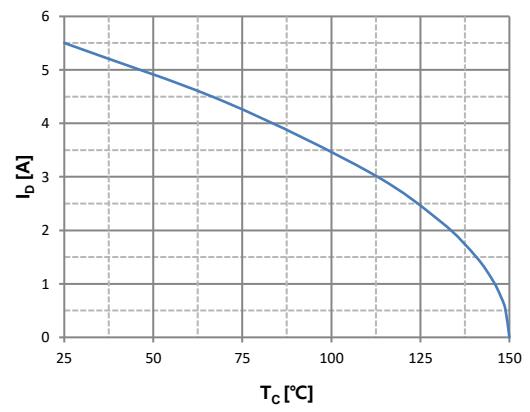
**Figure 7. Breakdown Voltage Variation vs. Temperature**



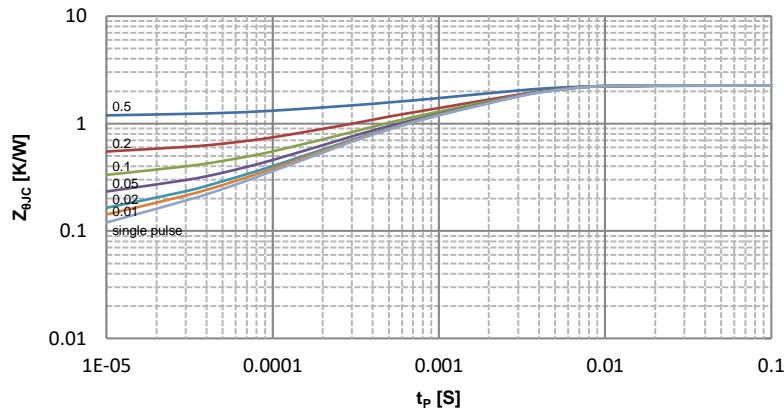
**Figure 8. On-Resistance Variation vs. Temperature**



**Figure 9. Maximum Safe Operating Area**

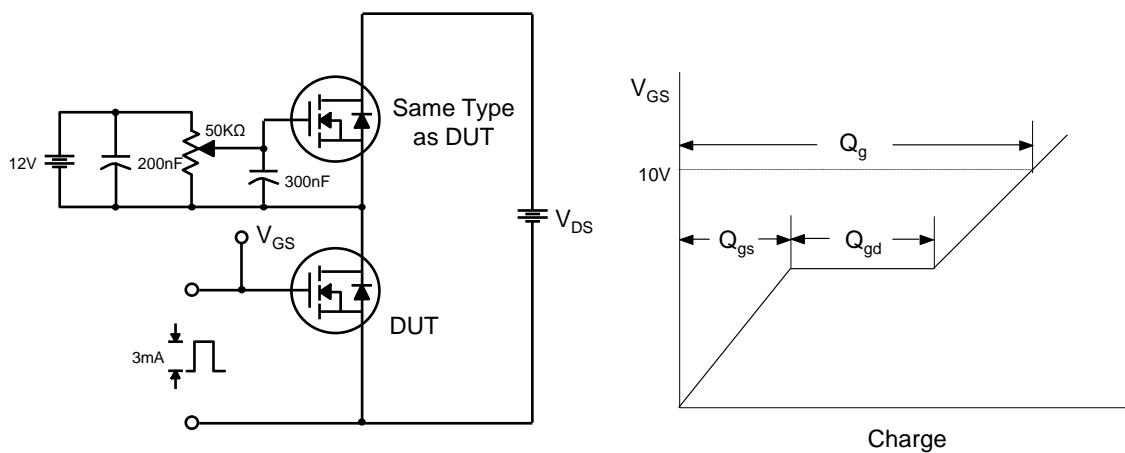


**Figure 10. Maximum Drain Current vs. Case Temperature**

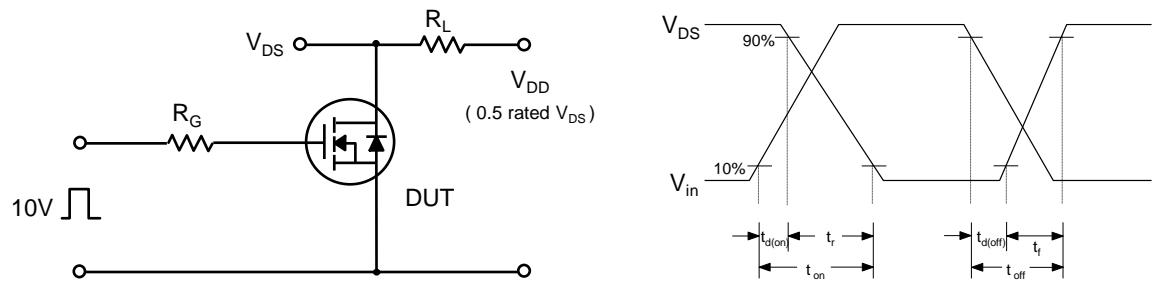


**Figure 11. Transient Thermal Response Curve**

**Fig 12. Gate Charge Test Circuit & Waveform**



**Fig 13. Resistive Switching Test Circuit & Waveforms**



**Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**

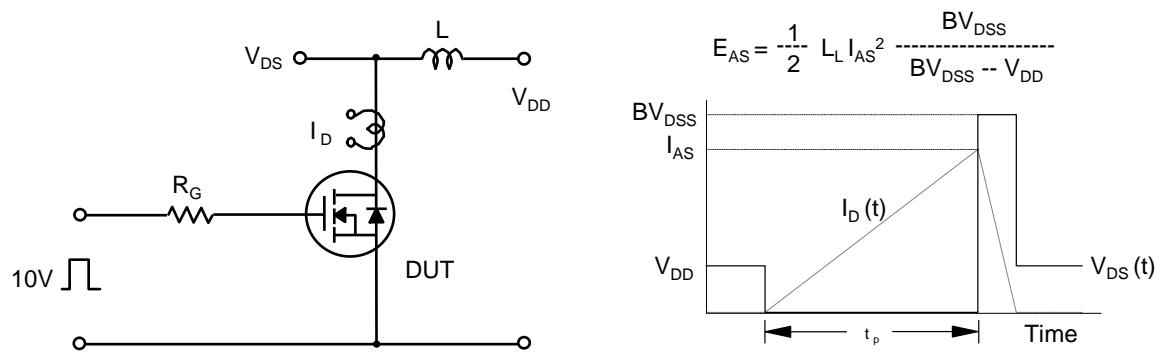
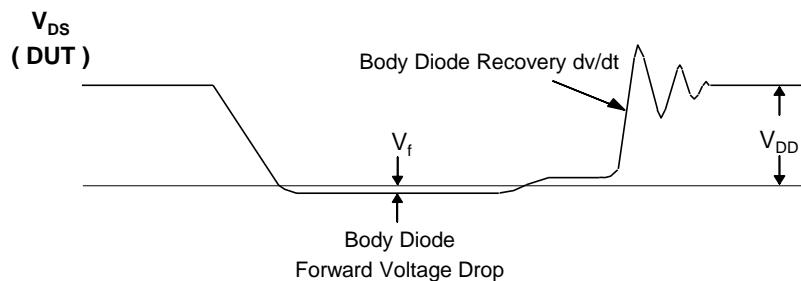
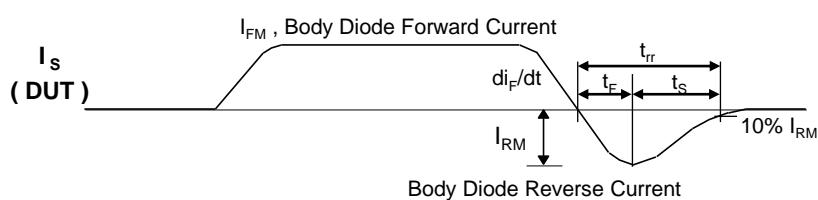
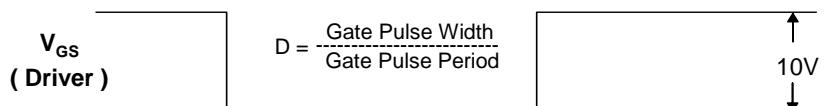
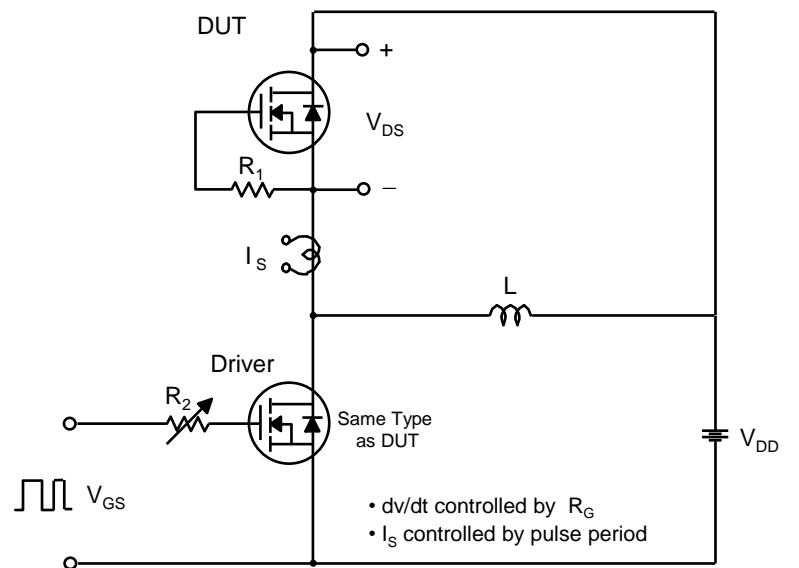


Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



## Package Dimension

D-PAK  
(TO-252A)